

Solving Warping Issues with Novel Metal Compressible TIM

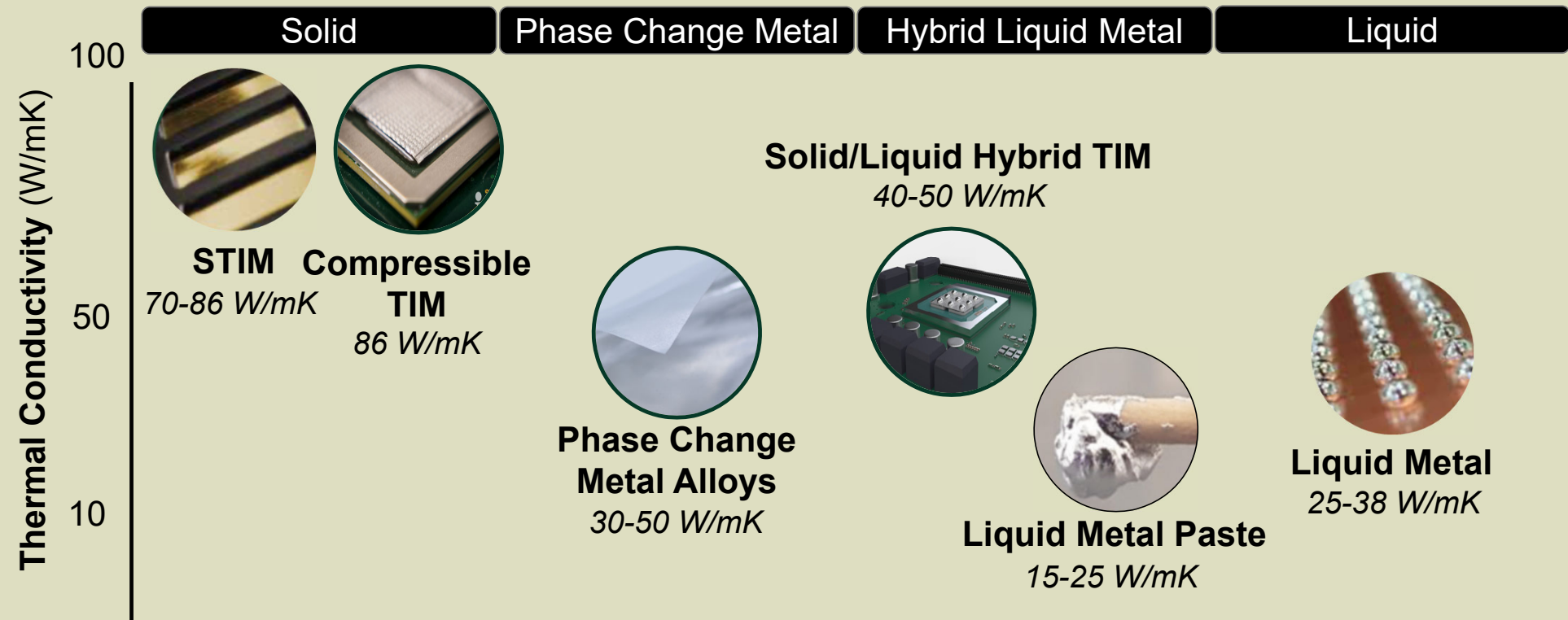
**Miloš Lazić
Bob Jarrett
Ricky McDonough
Carson Burt
Indium Corporation**



Mesa, Arizona • March 2–5, 2025

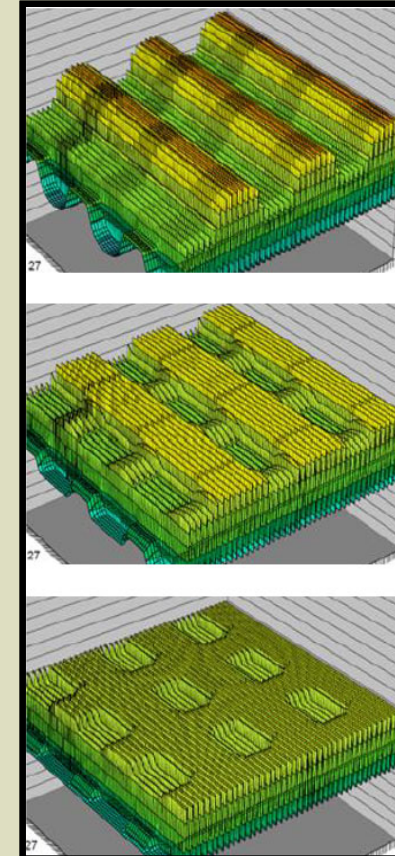


Metal TIMs

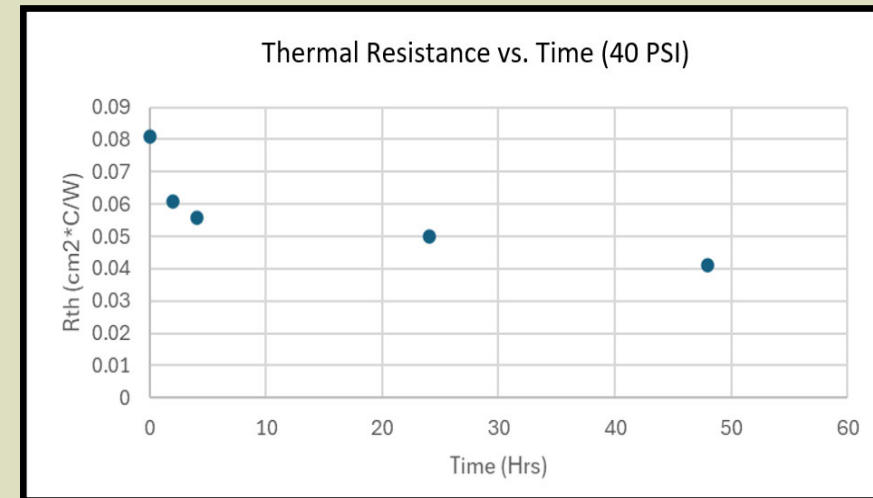
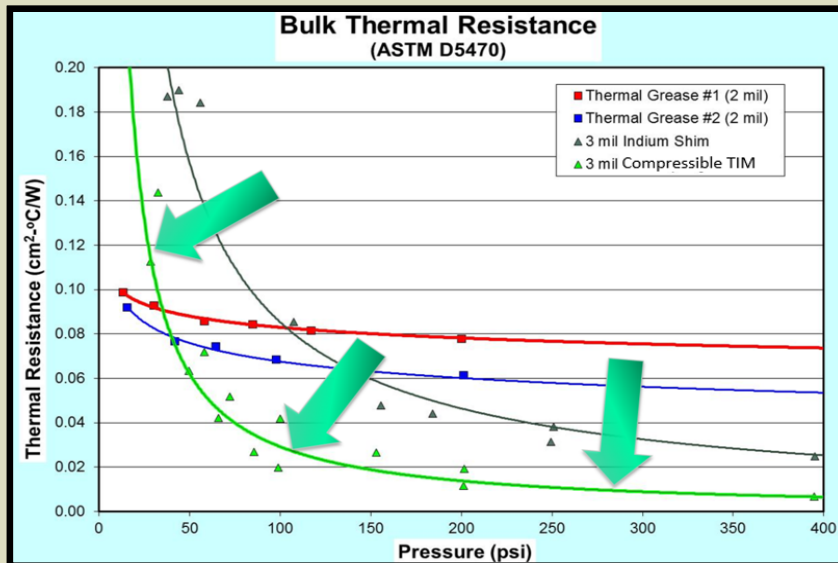


Compressible Metal TIM - Principles

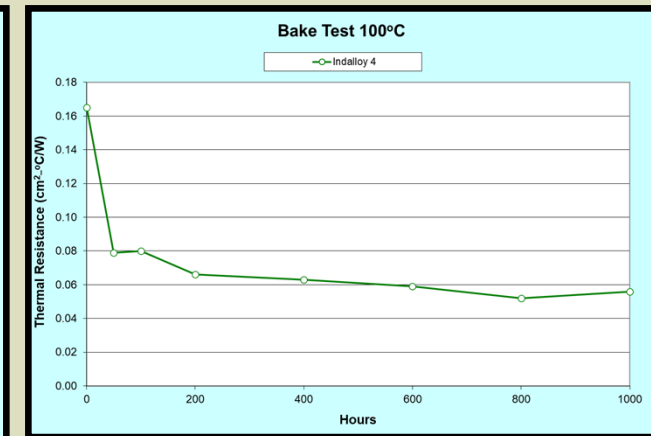
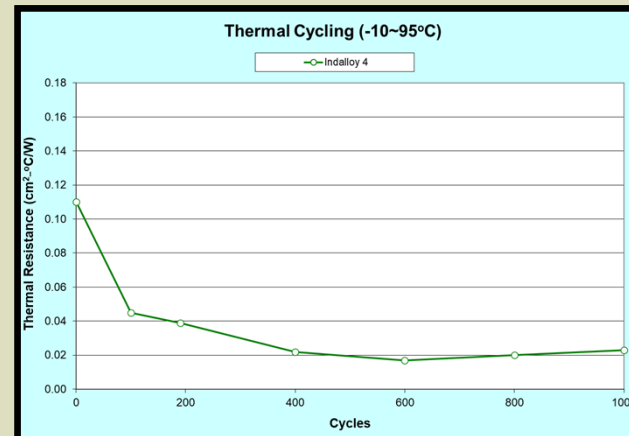
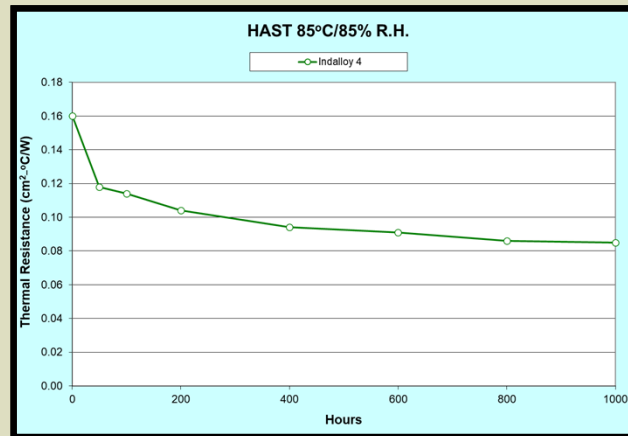
- Pattern applied to metal shim to form array of compressible columns
- Metal TIMs possess high thermal conductivity
 - Pure indium: 86 W/mK
 - TIM thickness has weak impact on thermal resistance
- Metal plastically deforms to the interfaces, thermal resistance decreases
 - Deformation through creep or optional preload



Compressible Metal TIM - Principles



Compressible Metal TIM - Reliability



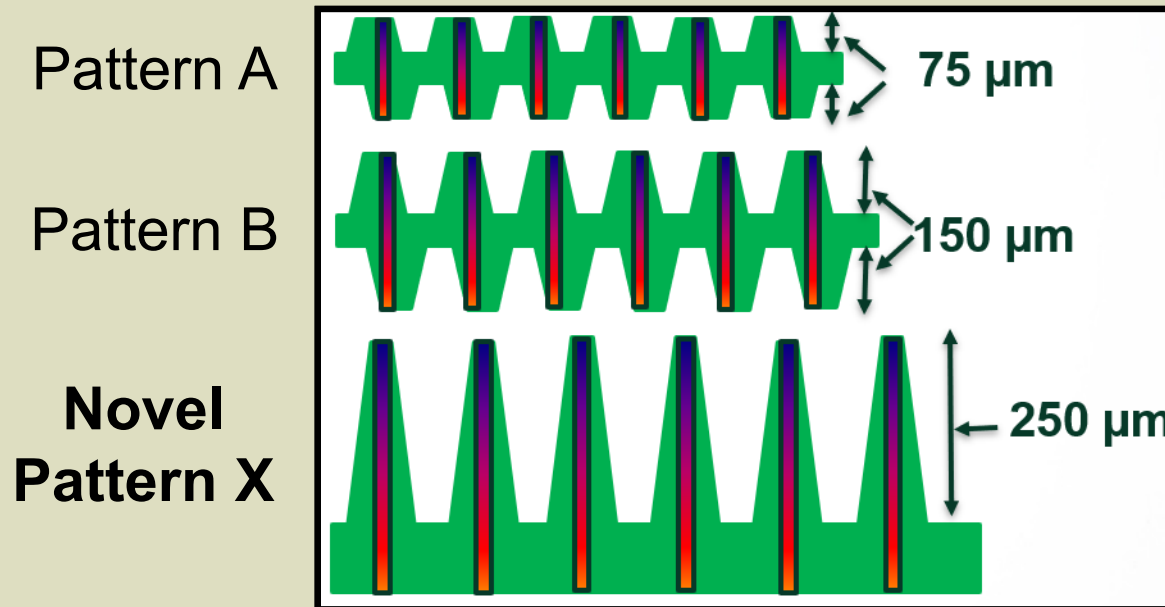
- TIM performance improves over time
- Pure indium metal – resistant to degradation
- No pump-out or bake-out
- Highly reworkable – easily removed, no residue



Solving Warping Issues with Novel Metal Compressible TIM

5 **2025**

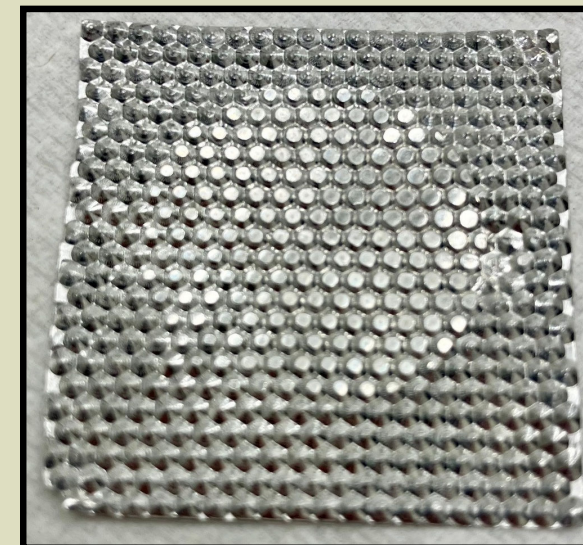
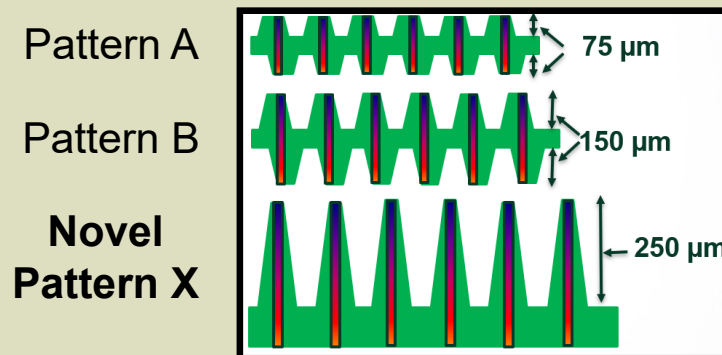
Compressible Metal TIM - Patterns



- **Pattern A:** Designed for parallel interfaces with tight surface control
- **Pattern B:** Higher profile variant of Pattern A with 2X compressibility
- **Pattern X:** Alternative pattern geometry for optimized compressibility at lower pressures

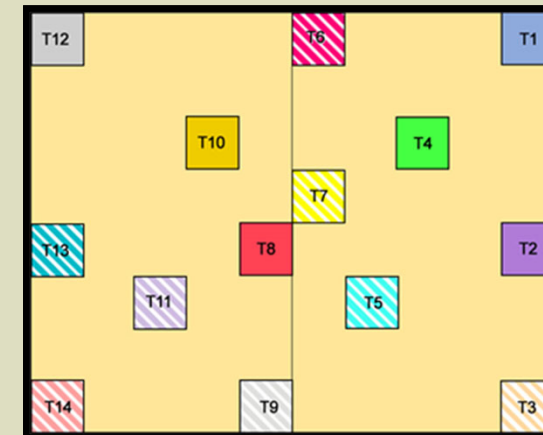
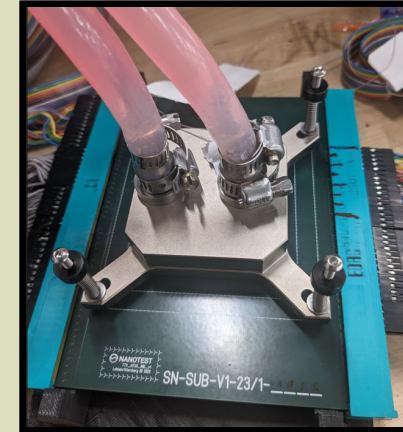
Compressible Metal TIM - Patterns

- Novel pattern is more compressible at lower pressures
- Recommended for non-planar/curved surfaces and applications with high CTE mismatch



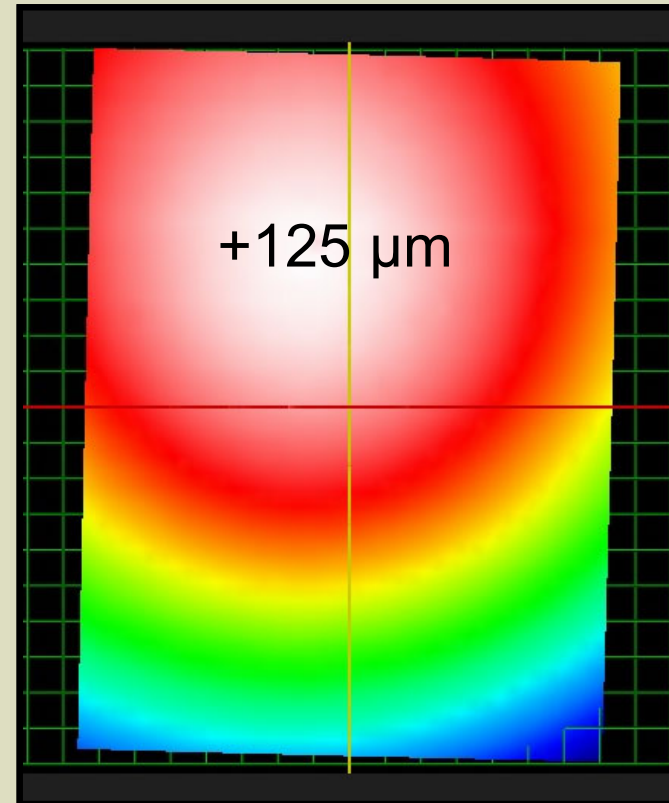
Thermal Test Vehicle (TTV) Assembly

- 20 x 25mm die
- Cycling power up to 1400W
- Heat sink & chiller used for heat removal
- ~ 20 seconds/cycle (300W),
~40 seconds/cycle (1000W)
- 14 RTD locations



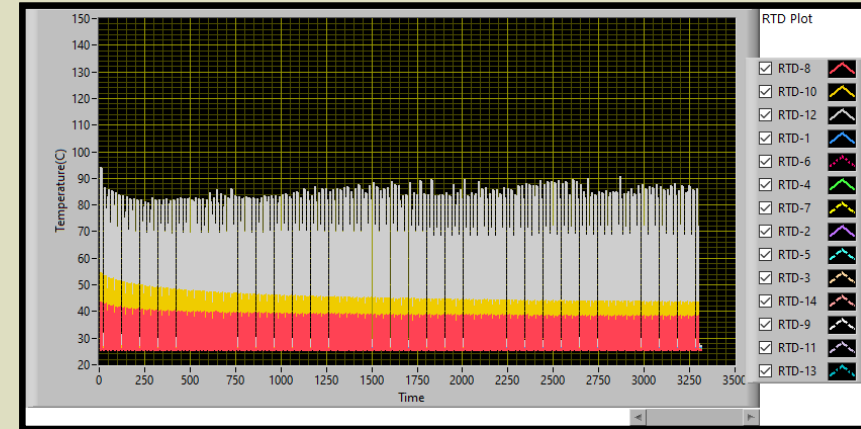
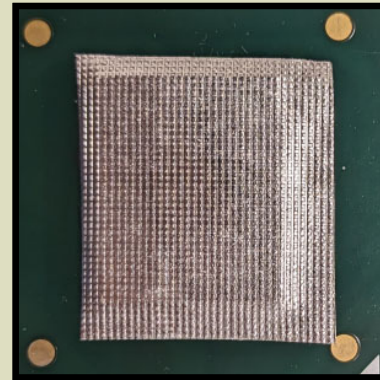
TTV Assembly – Die Profile

- Maximum crown
125 μm (5 mil)
 - Simulates non-coplanarity of production dies

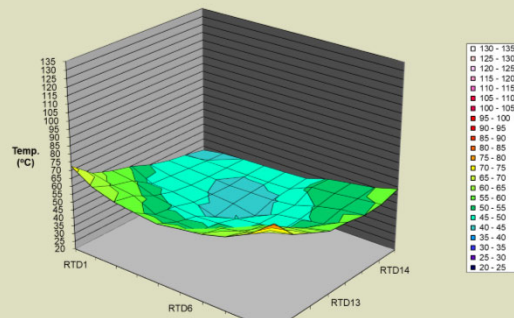


TTV - Pattern A, 50 psi, 0 – 300 W

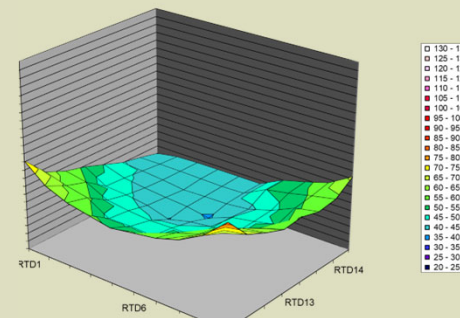
- Good baseline resistance
- Limited compliance, corners never make contact



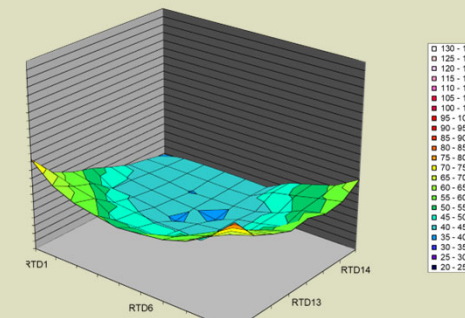
10 Cycles



50 Cycles



150 Cycles

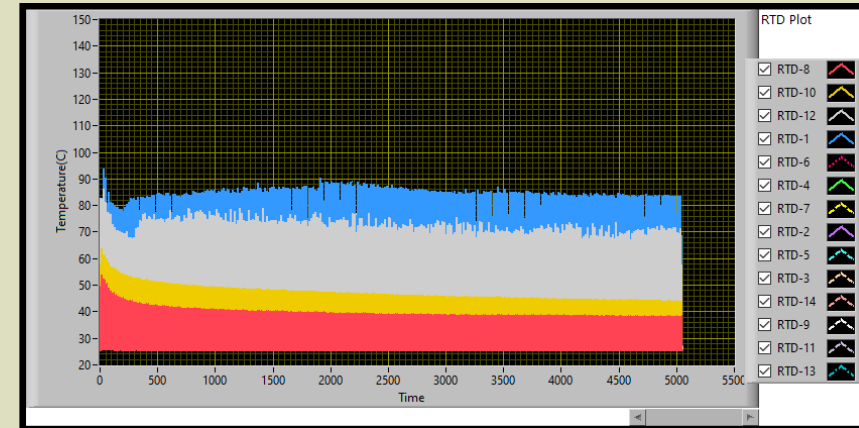
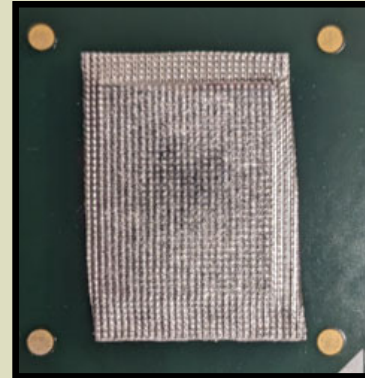


Solving Warping Issues with Novel Metal Compressible TIM

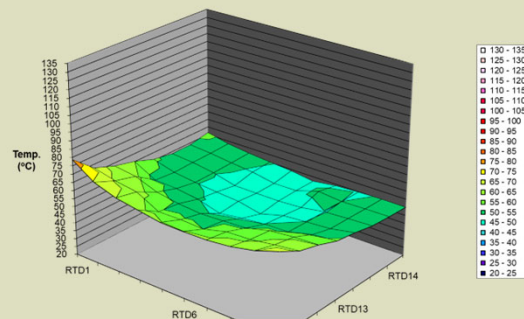
10 **2025**

TTV - Pattern B, 50 psi, 0 – 300 W

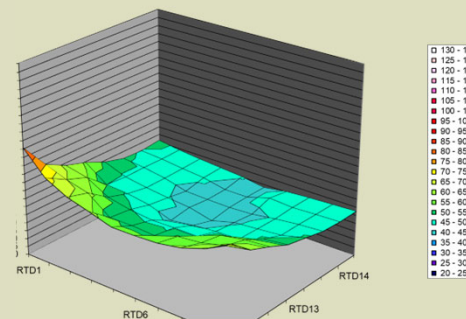
- Good baseline resistance
- Improved compliance, corners never make contact



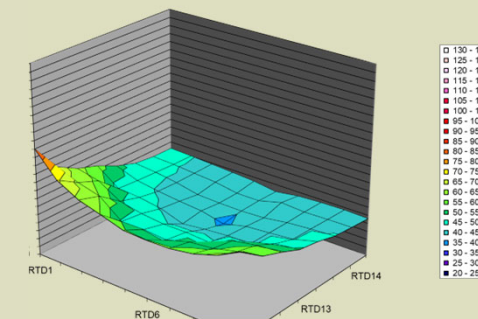
10 Cycles



50 Cycles

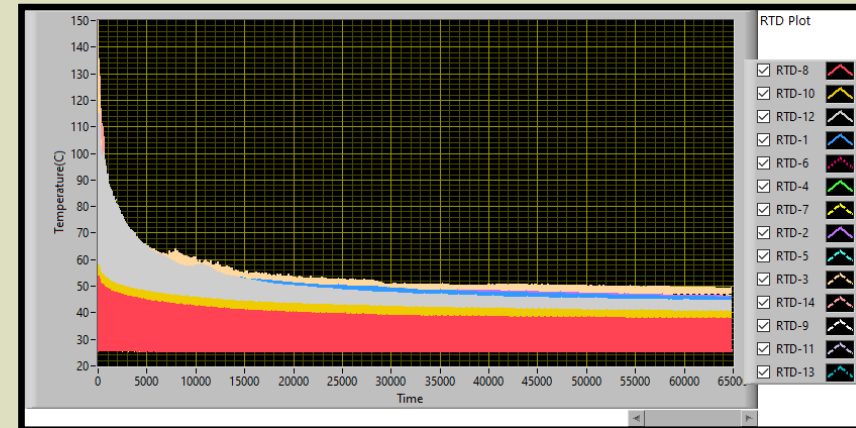
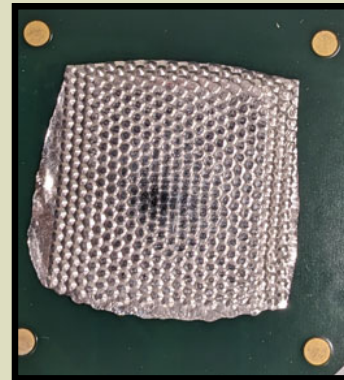


150 Cycles

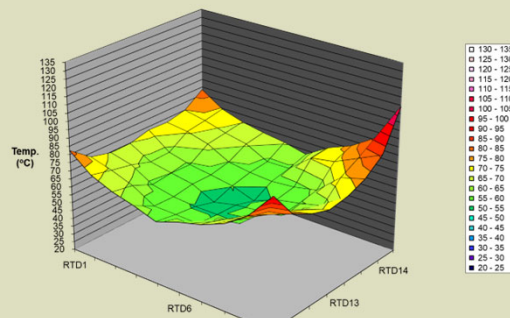


TTV - Pattern X, 50 psi, 0 – 300 W

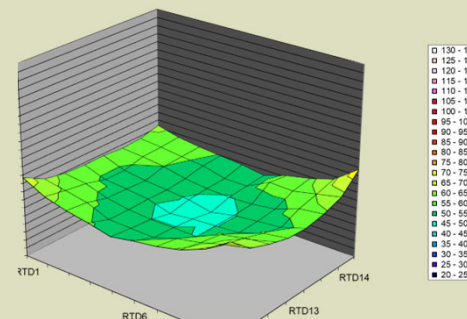
- Improved baseline resistance
- High compliance, corners make efficient contact through cycling



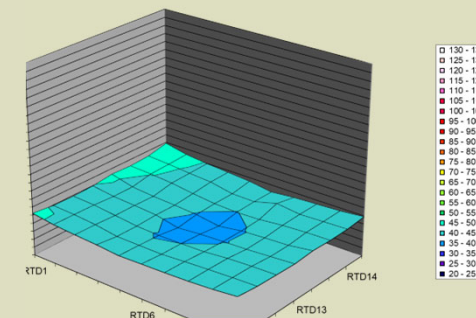
20 Cycles



124 Cycles



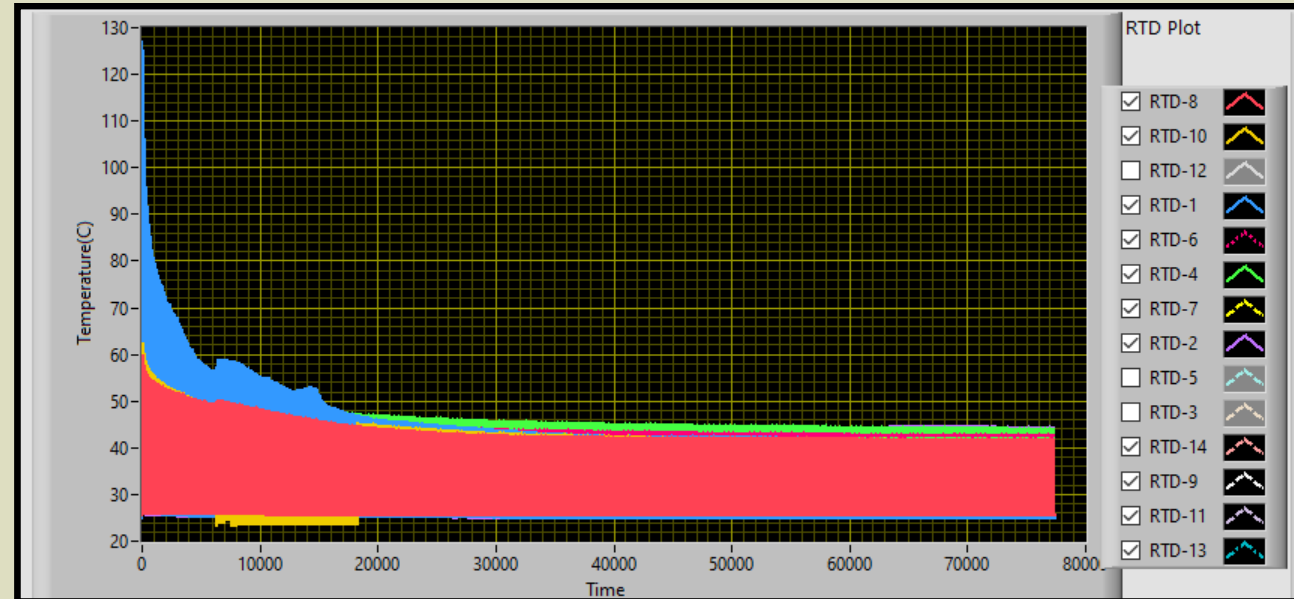
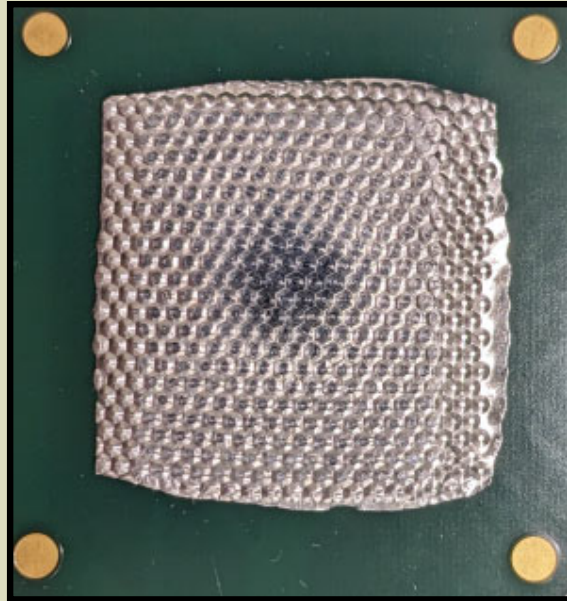
3240 Cycles



Solving Warping Issues with Novel Metal Compressible TIM

12 **2025**

TTV - Pattern X, 30 psi, 0 – 300 W



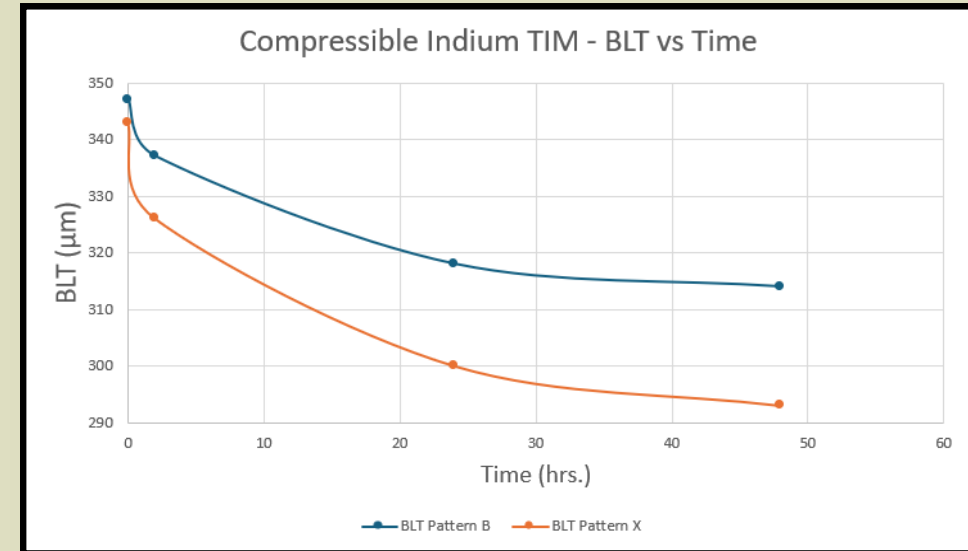
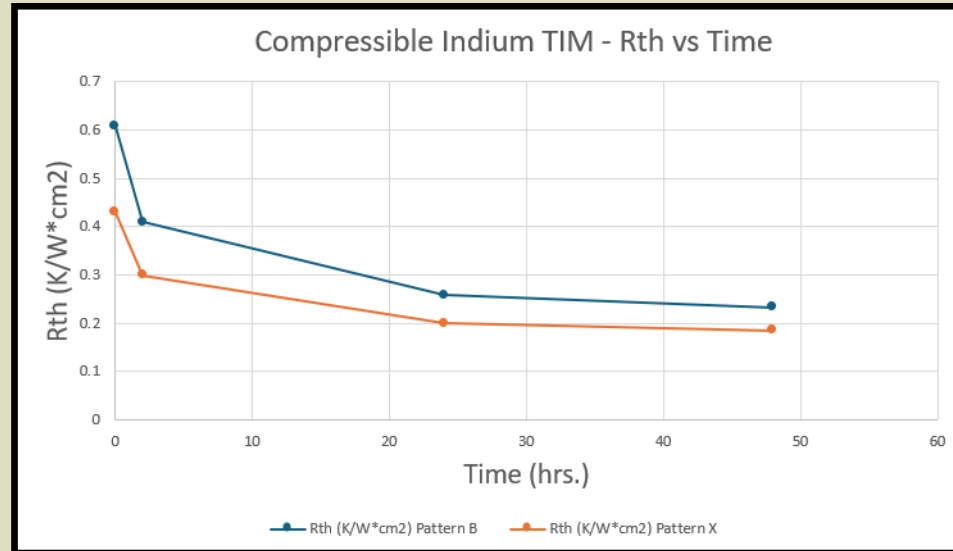
- At lower pressure, Pattern X exhibits lower, consistent temperature across die



Solving Warping Issues with Novel Metal Compressible TIM

13 **2025**

TIM Pattern Compression

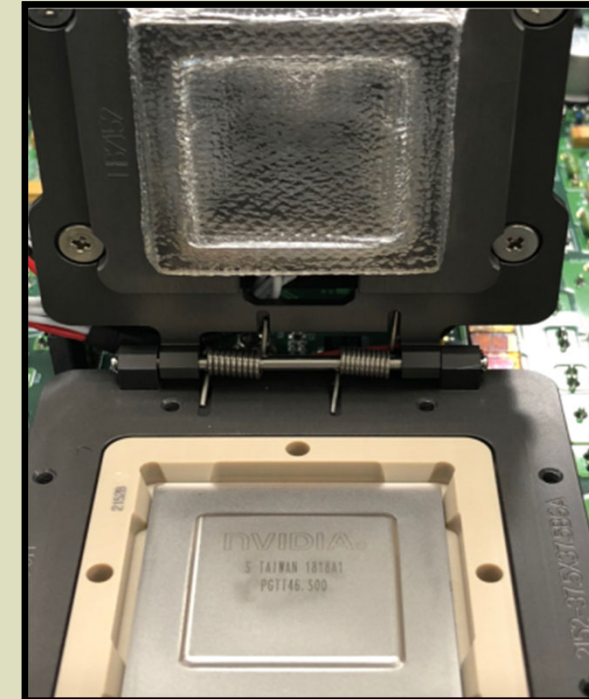
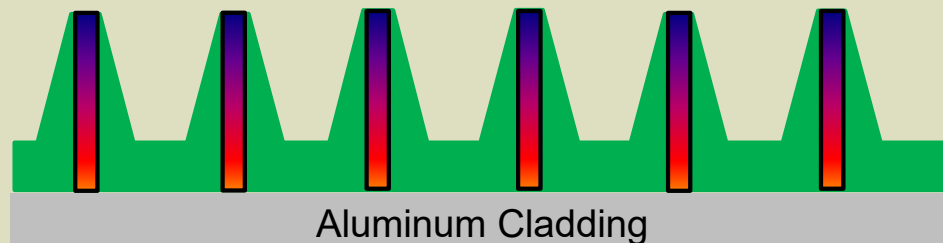


- 20 psi, 85°C, 0.012" overall thickness
- Novel Pattern X exhibits and maintains lower Rth and BLT over time
- Suitability for TIM1 and TIM1.5 applications

Compressible Metal TIM - Applications

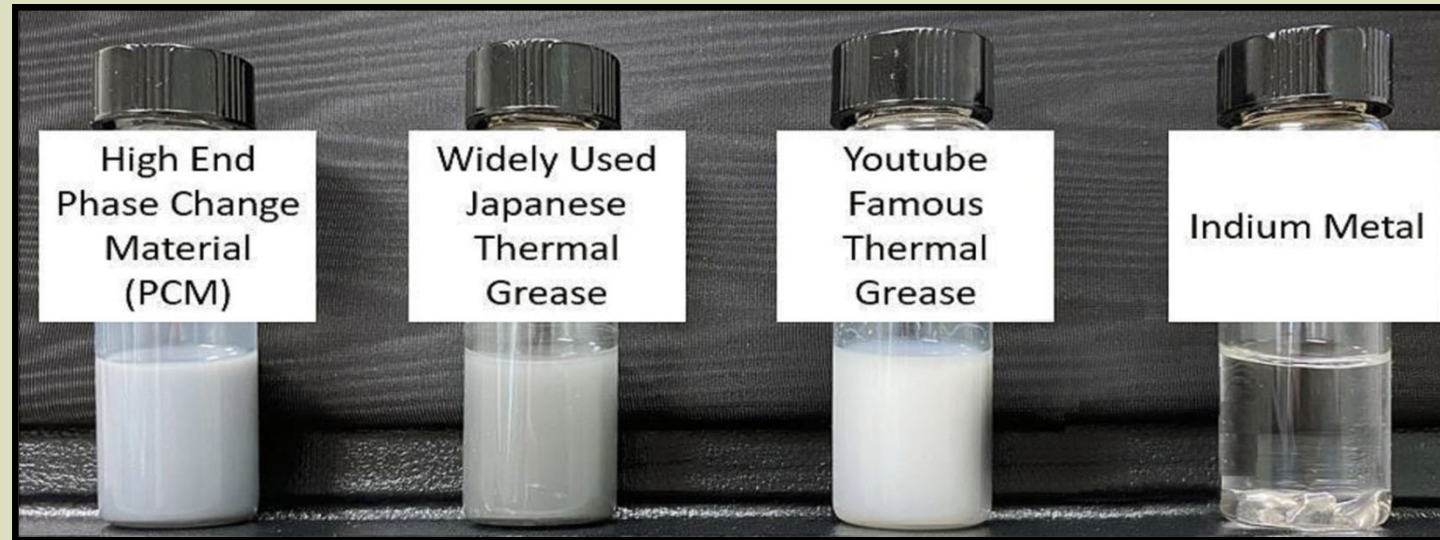
Semiconductor Test and Burn-in

- Thin aluminum cladding added to TIM
- Prevents indium diffusion into device under test (DUT)



Compressible Metal TIM - Applications

Immersion Cooling



- Indium compressible TIMs will not dissolve in or contaminate immersion fluid

Compressible Metal TIM - Considerations

Alloy Selection

Alloy	Solidus (°C)	Conductivity (W/mK)	Estimated Flow Stress (PSI)	Suggested Pressure (PSI)
100 In	157	86	175	30 - 40
52In48Sn	118	41	310	30 - 40
90In10Ag	143	71	700	60-80
Sn+	232	73	1000-2000	80-100

- Pure indium recommended for most applications
- Alternative alloy considerations:
 - TIM area and mechanism of compression
 - Maximum TIM operating temperature



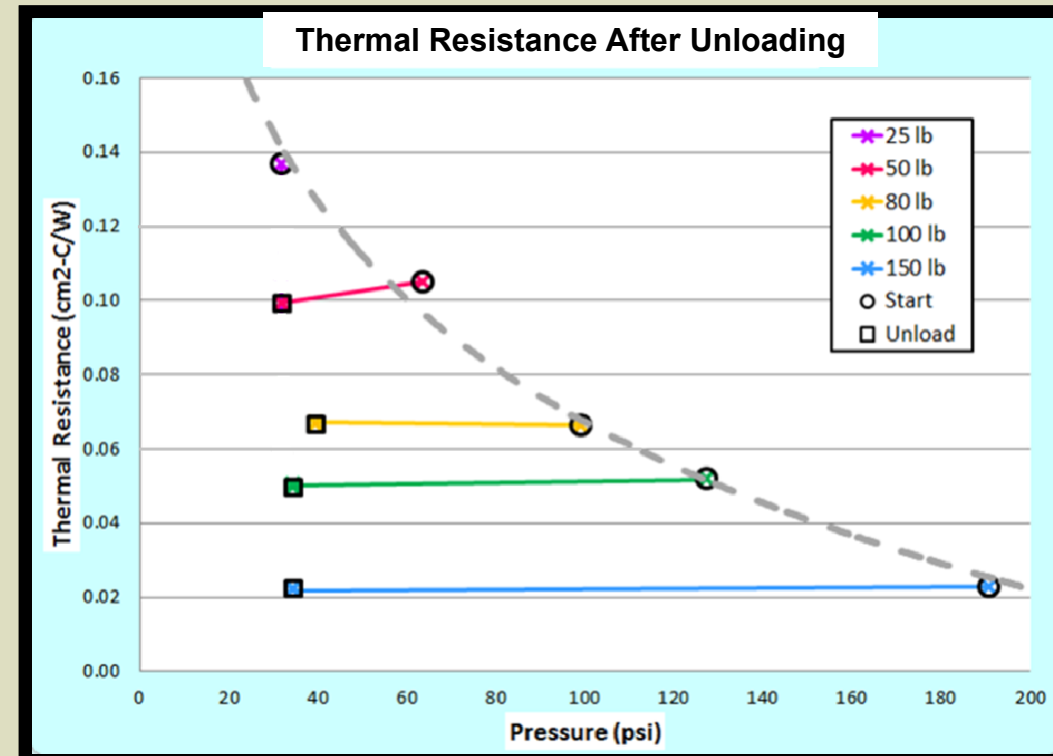
Solving Warping Issues with Novel Metal Compressible TIM

17 **2025**

Compressible Metal TIM - Considerations

Pre-load Effects

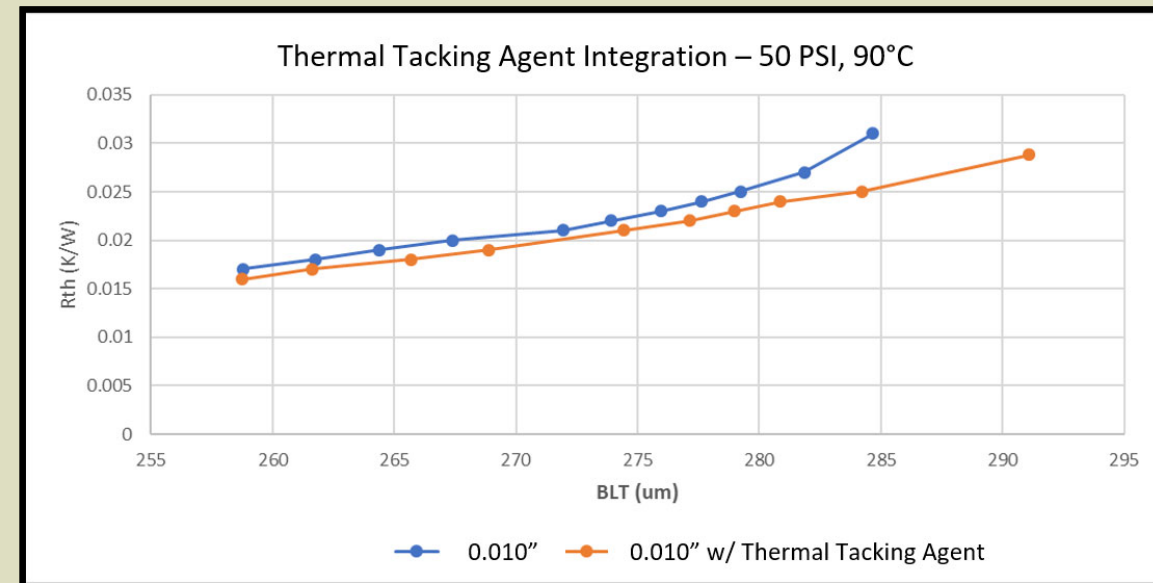
- Samples pre-loaded and unloaded
- Thermal resistance is determined by the contact formed at the peak load pressure
- Plastic deformation is maintained



Compressible Metal TIM - Considerations

Thermal Tacking Agent Integration

- Thermally conductive – improves thermal resistance (initial cycles)
- Maintains assembly alignment
- Not electrically conductive



Compressible Metal TIMs - Summary

- High-power applications require high-performing thermal interface materials
- TIM1 and TIM1.5 applications require metal compressible TIMs to have higher compliance at lower pressures
- Novel Pattern X TIM offers high compressibility, producing lower thermal resistance at lower pressures observed with curved, nonplanar surfaces



Solving Warping Issues with Novel Metal Compressible TIM

20 **2025**

Contributions/Acknowledgements

- [1] M. Lazić, S. Agarwal, “Liquid Metal Jetting for High-Performance Computing Applications”, iMAPS 2024
- [2] M. Lazić, “Liquid Metal TIMs,” SEMI-THERM 2019.
- [3] M. Lazić, R. McDonough, “High-Performance Phase Change Metal TIMs,” IPC APEX Expo 2023
- [4] M. Lazić, S. Agarwal, “A Jettable and Dispensable Liquid Metal Paste as a Thermal Interface Material”, iMAPS 2023
- [5] M. Lazić, “A New High Viscosity Liquid Metal Paste for Thermal Management”, SEMI-THERM 2022.
- [6] M. Lazić, A. Mackie, T. Jensen, D. Socha, “Solid Liquid Hybrid TIMs”, PCB Carolina



Solving Warping Issues with Novel Metal Compressible TIM

21 **2025**

Presentation / Copyright Notice

The presentations in this publication comprise the pre-workshop Proceedings of the 2025 TestConX workshop. They reflect the authors' opinions and are reproduced here as they are planned to be presented at the 2025 TestConX workshop. Updates from this version of the papers may occur in the version that is actually presented at the TestConX workshop. The inclusion of the papers in this publication does not constitute an endorsement by TestConX or the sponsors.

There is NO copyright protection claimed by this publication. However, each presentation is the work of the authors and their respective companies: as such, it is strongly encouraged that any use reflect proper acknowledgement to the appropriate source. Any questions regarding the use of any materials presented should be directed to the author/s or their companies.

The TestConX logo and 'TestConX' are trademarks of TestConX.